

SGL041-02

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Application of the finer-separated illite in fault gouge for K-Ar dating

Seiko Yamasaki^{1*}, Kunimi Yamada¹, Takahiro Tagami², Horst Zwingmann³

¹JAEA, ²Kyoto University, ³CSIRO

Direct dating of fault gouges can be critical for the age determination of brittle deformation when the timing is difficult to constrain from stratigraphical and geomorphological methods. We present the K-Ar age data for two fault gouge samples corrected from the Mizunami Underground Research Laboratory. The gouge samples were separated into four grain-size fractions of <0.1, <0.4, <2, 2-6 micrometer by using high speed centrifuge. The finer-size fractions yield younger K-Ar ages, suggesting that the finer-size fractions contain a high degree of authigenic illite. And, the K-Ar ages of the finer-size fractions were bracket by fission track ages of zircon and apatite separated from the wall rocks, indicating the illite grew at temperatures in the range about 100-250 degree Celsius, consistent with the stability of illite. These observations demonstrate the applicability of this method for direct dating of brittle deformation.